

<b>Notice of References Cited</b>	Application/Control No. 10/814,868	Applicant(s)/Patent Under Reexamination DIORIO ET AL.	
	Examiner Son L. Mai	Art Unit 2827	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0122331 A1	09-2002	Santin et al.	365/185.09
*	B	US-2005/0149896 A1	07-2005	Madurawe, Raminda Udaya	716/017
*	C	US-5,124,568 A	06-1992	Chen et al.	327/217
*	D	US-5,659,498 A	08-1997	Pascucci et al.	365/154
*	E	US-5,731,716 A	03-1998	Pascucci, Luigi	326/106
*	F	US-5,892,712 A	04-1999	Hirose et al.	365/185.07
*	G	US-5,912,937 A	06-1999	Goetting et al.	377/67
*	H	US-6,111,785 A	08-2000	Hirano, Yasuaki	365/185.09
*	I	US-6,331,949 B1	12-2001	Hirano, Yasuaki	365/185.09
*	J	US-6,363,011 B1	03-2002	Hirose et al.	365/185.07
*	K	US-6,590,825 B2	07-2003	Tran et al.	365/225.7
*	L	US-6,654,272 B2	11-2003	Santin et al.	365/96
*	M	US-6,693,819 B2	02-2004	Smith et al.	365/154

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.